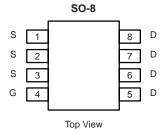


**RoHS** COMPLIANT

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# P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
- 30	0.008 at V <sub>GS</sub> = 10 V	- 15	27 nC			
	0.011 at $V_{GS}$ = 4.5 V	- 13.7	27 110			

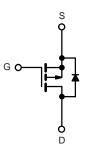


#### **FEATURES**

- DT-Trench Power MOSFET
- 100 % R<sub>g</sub> Tested

#### APPLICATIONS

- Load Switches
  - Notebook PCs
- Desktop PCs



P-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	<b>IGS</b> T <sub>A</sub> = 25 °C,	unless othe	erwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		- 15		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 12.7		
Continuous Drain Current $(1_j = 150^{\circ} C)$	T <sub>A</sub> = 25 °C		- 13 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 10.4 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	- 50		
Continuus Courses Drain Diada Current	T <sub>C</sub> = 25 °C	1	- 4.7		
Continous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 2.1 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C	– P <sub>D</sub>	5.7		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		3.6	w	
	T <sub>A</sub> = 25 °C		2.5 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C	1	1.6 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical Maximum		Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	35	50	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	18	22	0/11	

Notes:

a. Based on  $T_C = 25 \ ^{\circ}C$ .

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-				•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 2504		- 20		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		4.9			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1		
		$V_{DS}$ = - 30 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			- 5	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le$ - 5 V, $V_{GS}$ = - 10 V	- 30			Α	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 13 A		0.008	0.009		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		0.011	0.013	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 13 A		40		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			2610		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		460			
Reverse Transfer Capacitance	C <sub>rss</sub>			395			
	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 13 A		53	80	nC	
Total Gate Charge				27	41		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 13 A		8			
Gate-Drain Charge	Q <sub>gd</sub>			13			
Gate Resistance	Rg	f = 1 MHz	0.4	2.1	4.2	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			52	78	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, R <sub>L</sub> = 1.5 $\Omega$		41	62		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\rm I_D \cong$ - 10 A, $\rm V_{GEN}$ = - 4.5 V, $\rm R_g$ = 1 $\Omega$		36	54		
Fall Time	t <sub>f</sub>			15	25		
Turn-On Delay Time	t <sub>d(on)</sub>			12	20		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, R <sub>L</sub> = 1.5 $\Omega$		9	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong$ - 10 A, $\text{V}_\text{GEN}$ = - 10 V, $\text{R}_\text{g}$ = 1 $\Omega$		42	63		
Fall Time	t <sub>f</sub>			9	15		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 4.7	٨	
Pulse Diode Forward Current	I <sub>SM</sub>				- 50	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 10 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			20	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		10	20	nC	
Reverse Recovery Fall Time	ta			10			
Reverse Recovery Rise Time	t <sub>b</sub>			9	l	ns	

Notes:

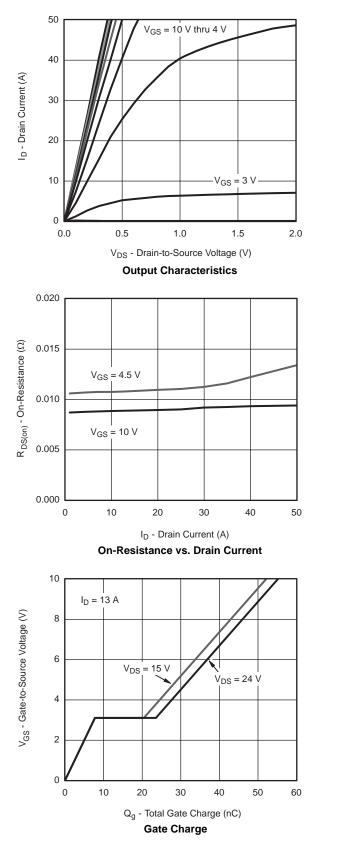
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

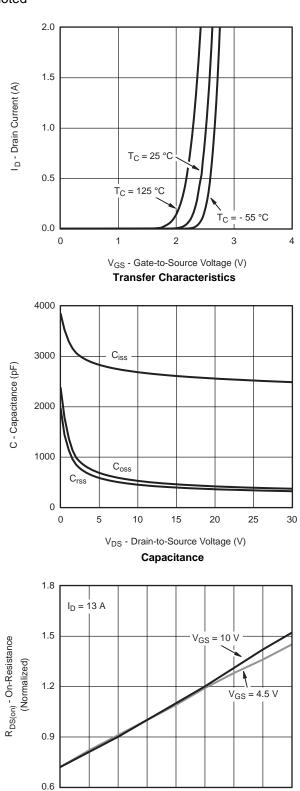
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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T<sub>J</sub> - Junction Temperature (°C) On-Resistance vs. Junction Temperature

50

75

100

125 150

- 50

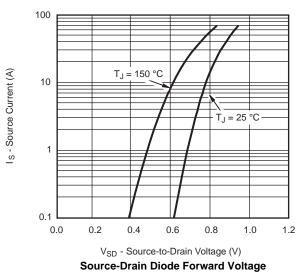
- 25

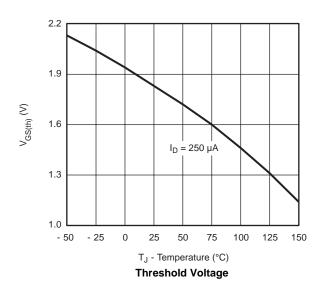
0

25

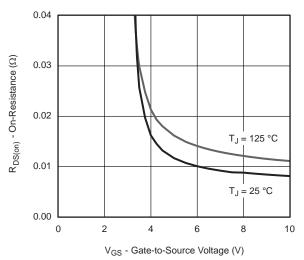
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

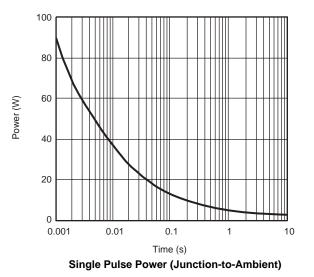


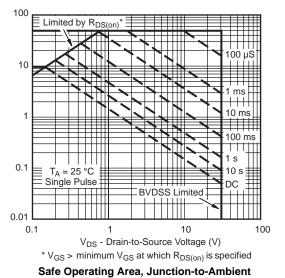


I<sub>D</sub> - Drain Current (A)



On-Resistance vs. Gate-to-Source Voltage

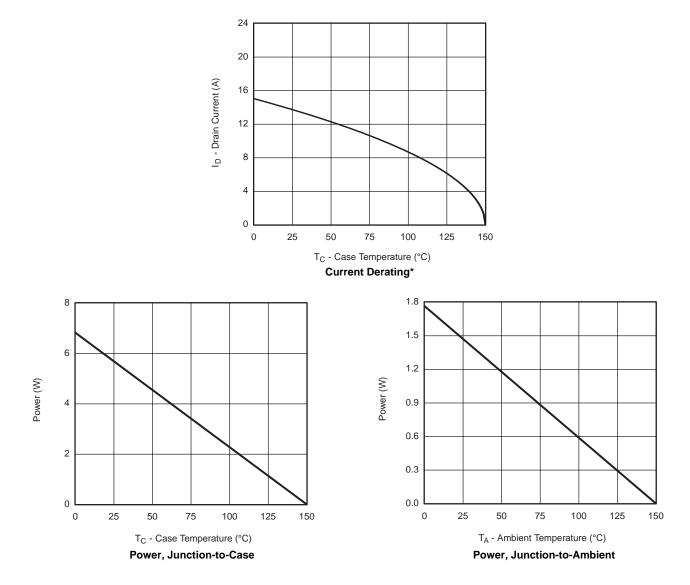






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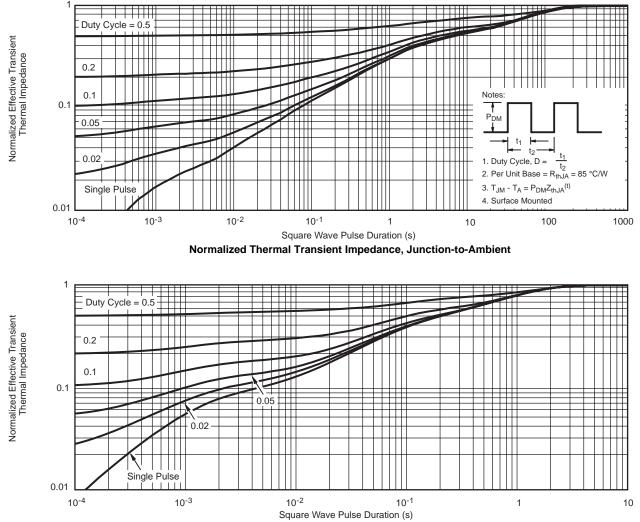
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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Normalized Thermal Transient Impedance, Junction-to-Foot



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